

Notice of References Cited	Application/Control No. 10/530,541	Applicant(s)/Patent Under Reexamination KLOTZ ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,219,358	08-1980	Hayashi et al.	106/1.17
*	B	US-4,537,632	08-1985	Mosser, Mark F.	106/14.12
*	C	US-5,478,413	12-1995	Mosser et al.	148/261
*	D	US-5,998,525	12-1999	Wang et al.	524/425
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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